## Notice of References Cited Application/Control No. 10/574,015 Examiner REDHWAN MAWARI Applicant(s)/Patent Under Reexamination AKIYOSHI ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-6,049,754 A	04-2000	Beaton et al.	701/204
*	В	US-2001/0029429 A1	10-2001	Katayama et al.	701/209
*	C	US-2002/0004700 A1	01-2002	Klein, Bernhard	701/200
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Η	US-			
	-	US-			
	J	US-			
	К	US-			
	┙	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	Ν					
	0					
	Р					
	Ø					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	C					
	>					
	w					
	х					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.